

Search Notes

Application/Control No.

10/820,181

Examiner

Isaac M. Woo

Applicant(s)/Patent under
Reexamination

YIP ET AL.

Art Unit

2166

SEARCHED

Class	Subclass	Date	Examiner
707	1-10	2/6/2008	IW
707	100-104.1	2/6/2008	IW
707	200-206	2/6/2008	IW

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
PGPUB&USPAT- text search - See history search printout		2/6/2008	IW

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See search history printout(s), ACM, IEEE, Google.	2/6/08	IW